

# Modeling Physical Interconnects

(Part 2)

**Dr. José Ernesto Rayas Sánchez**

1

## Outline

---

- Stripline
- Stripline geometry and field distribution
- Characterizing striplines
- Fabrication of PCBs (stackup)
- Microstrip line
- Microstrip geometry and field distribution
- Characterizing microstrip lines
- Embedded microstrips
- Losses in striplines and microstrip lines

## Striplines

---

- A stripline trace is immersed in a dielectric and sandwiched between two metallic planes
- The electric and magnetic fields are confined to the dielectric (TEM propagation if losses are small)

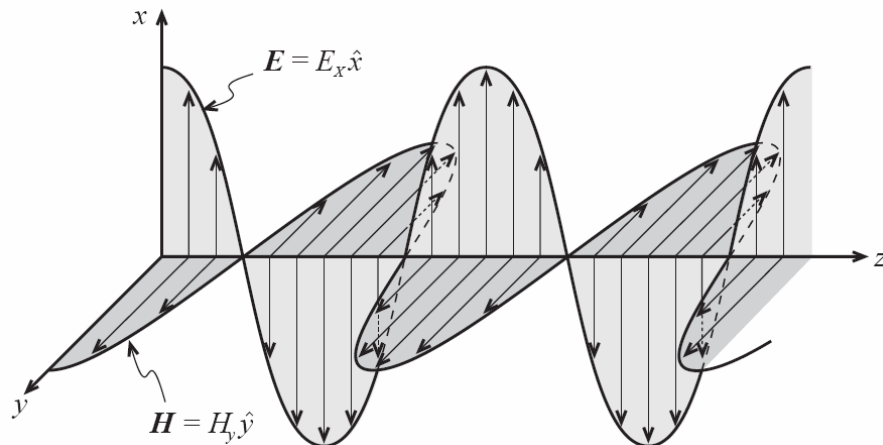
Dr. J.E. Rayas Sánchez

3

## TEM Propagation

---

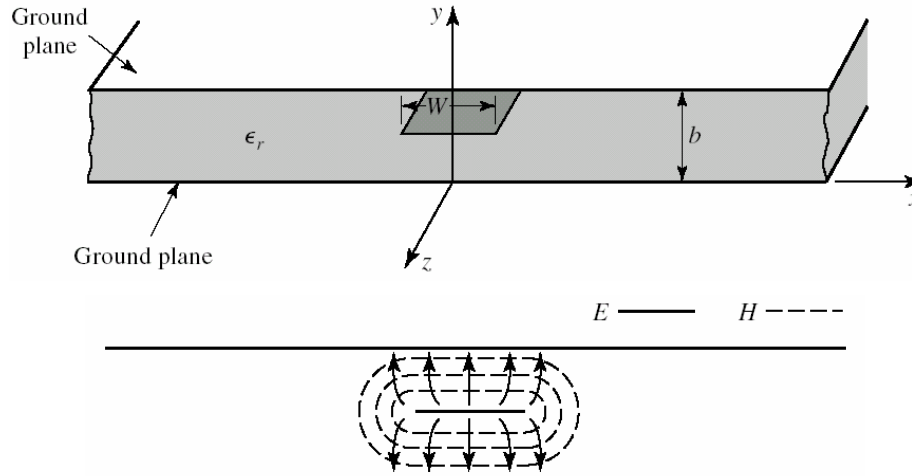
The electric and magnetic fields in the direction of propagation are zero



Dr. J.E. Rayas Sánchez

(R. Ludwig and P. Bretchko, *RF Circuit Design*, Prentice Hall, 2000)<sub>4</sub>

## Stripline Geometry and Field Distribution

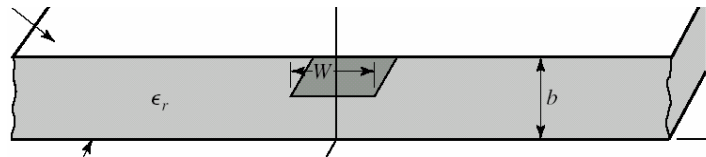


$$v_p = \frac{c}{\sqrt{\epsilon_e}} \quad \epsilon_e = \epsilon_r \quad c = 300 \text{ Mm/s}$$

Dr. J.E. Rayas Sánchez

(D. M. Pozar, *Microwave Engineering*, Wiley, 2005) <sub>5</sub>

## Characterizing Striplines (Zero Thickness)



$$Z_o = \frac{30\pi}{\sqrt{\epsilon_r}} \frac{b}{(W_e + 0.44b)}$$

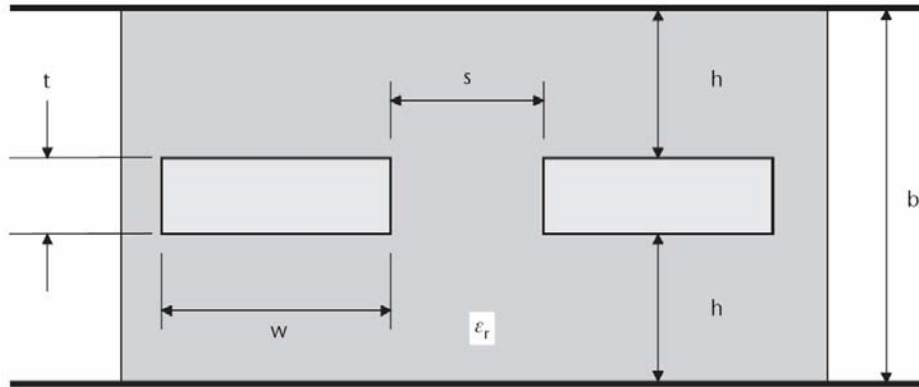
where  $W_e$  is the effective width given by

$$\frac{W_e}{b} = \frac{W}{b} \begin{cases} 0 & \text{for } \frac{W}{b} \geq 0.35 \\ (0.35 - \frac{W}{b})^2 & \text{for } \frac{W}{b} \leq 0.35 \end{cases}$$

Dr. J.E. Rayas Sánchez

(D. M. Pozar, *Microwave Engineering*, Wiley, 2005) <sub>6</sub>

## Characterizing Striplines (Non Zero Thickness)



Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004) <sub>7</sub>

## Characterizing Striplines (Non Zero Thickness)

$$Z_o = \frac{94.15}{\sqrt{\epsilon_r} \left( \frac{w}{b} k + \frac{C_f}{8.854 \epsilon_r} \right)} \quad \text{for } \frac{w}{b-t} \geq 0.35$$

where

$$k \equiv \frac{1}{1 - \frac{t}{b}}$$

and  $C_f$  is the fringing capacitance given by

$$C_f = \frac{8.854 \epsilon_r}{\pi} [2k \ln(k+1) - (k-1) \ln(k^2-1)] \quad (\text{pF/m})$$

Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004) <sub>8</sub>

## Characterizing Striplines (Non Zero Thickness)

$$Z_o = \frac{60}{\sqrt{\epsilon_r}} \ln\left(\frac{4b}{\pi d}\right) \text{ for } \frac{w}{b-t} < 0.35$$

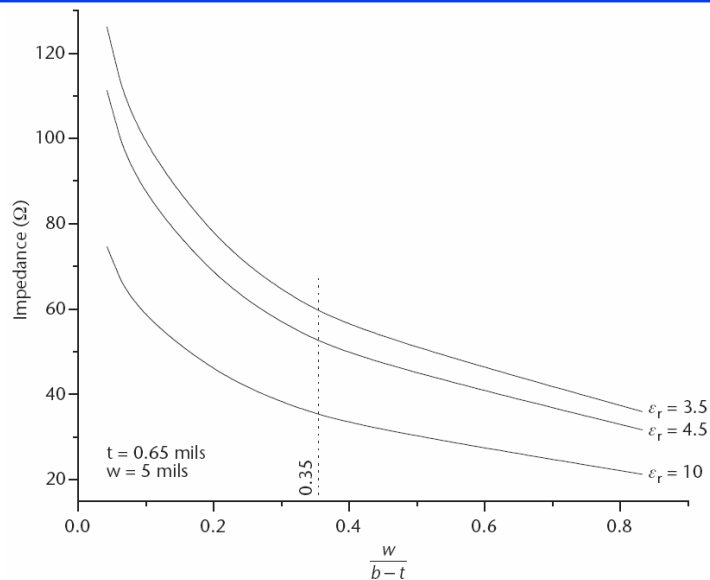
where

$$d = \frac{w}{2} \left\{ 1 + \frac{t}{\pi w} \left[ 1 + \ln\left(\frac{4\pi w}{t}\right) + 0.51\pi \left(\frac{t}{w}\right)^2 \right] \right\}$$

Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004) <sub>9</sub>

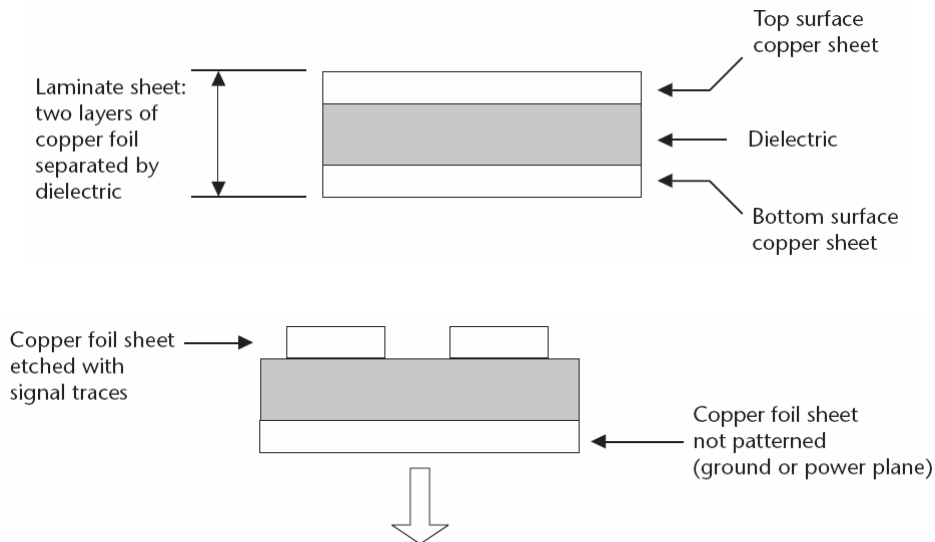
## Characterizing Striplines (Non Zero Thickness)



Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004) <sub>10</sub>

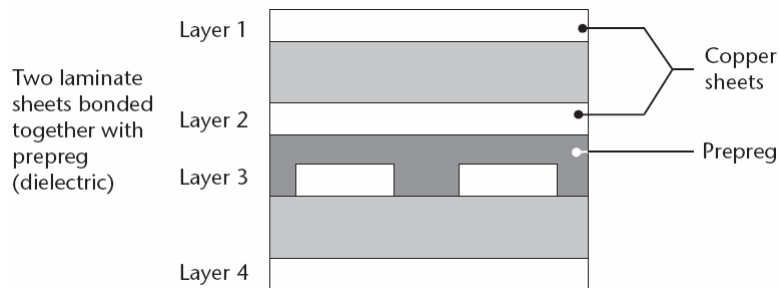
## Fabrication of PCB Stackup



Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>11</sub>

## Fabrication of PCB Stackup (cont)



**Table 9.1** Differences in Hi-TG FR4 Laminate and Prepreg  $\epsilon_r$

Case	Prepreg Thickness (mils)/ $\epsilon_r$	Core Thickness (mils)/ $\epsilon_r$	Change $\epsilon_r$
1	4.8/4.36	5.2/4.60	5.5%
2	4.8/4.36	22/4.65	6.7%
3	4.7/3.65	3.8/4.19	14.7%

Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>12</sub>

☺ PCB manufacturers usually select the laminate and prepreg thickness of each layer

☹ Identical routing patterns can have different times of flight on the same PCB

## Microstrips

---

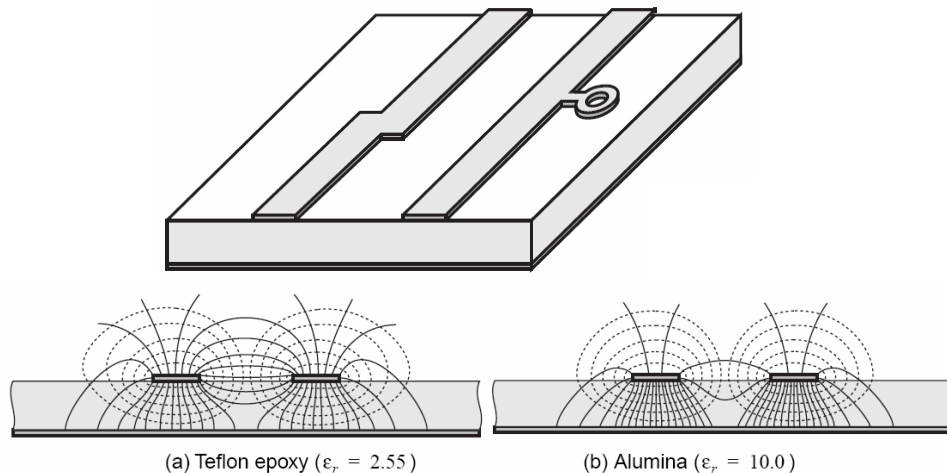
- A microstrip trace is sandwiched between two very different dielectrics
- Due to this non-homogeneous media, microstrips propagate in non TEM mode
- Using the effective dielectric constant approach, microstrips can be modeled as if they had an homogeneous media (quasi TEM propagation if the losses are small)

Dr. J.E. Rayas Sánchez

13

## Microstrip Geometry and Field Distribution

---

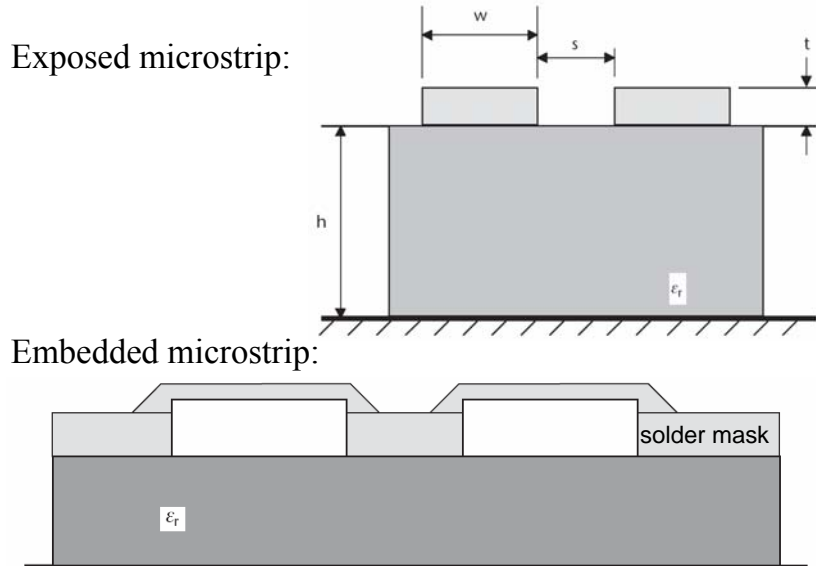


Substrates with higher  $\epsilon_r$  reduce field leakage and cross coupling  
Substrates with smaller  $\epsilon_r$  reduce dielectric losses

Dr. J.E. Rayas Sánchez

(*R. Ludwig and P. Bretchko, RF Circuit Design, Prentice Hall, 2000*)<sub>4</sub>

## Microstrip Geometry (cont)

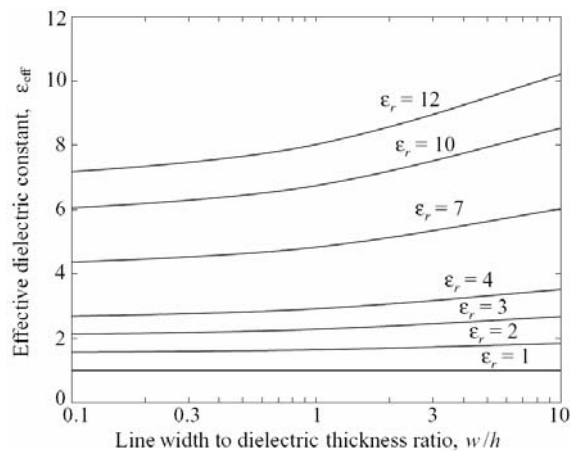


Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>15</sub>

## Characterizing Exposed Microstrip Lines

$$v_p = \frac{c}{\sqrt{\epsilon_e}} \quad c = 300\text{Mm/s} \quad \epsilon_e = \frac{\epsilon_r + 1}{2} + \frac{\epsilon_r - 1}{2\sqrt{1 + (10h/w)}}$$



Dr. J.E. Rayas Sánchez

(R. Ludwig and P. Bretchko, *RF Circuit Design*, Prentice Hall, 2000)<sub>16</sub>



## Characterizing Exposed Microstrip Lines (cont)

---

$Z_o$  neglecting thickness ( $t = 0$ )

Model 1: Walker's formulae

$$\text{if } \frac{w}{h} \leq 1, \quad Z_o = \frac{60}{\sqrt{\epsilon_e}} \ln\left(\frac{8h}{w} + \frac{w}{4h}\right) \quad \Omega$$

$$\text{if } \frac{w}{h} > 1, \quad Z_o = \frac{120\pi}{\sqrt{\epsilon_e}} \frac{1}{\left(\frac{w}{h}\right) + 2.42 - 0.44\left(\frac{h}{w}\right) + \left(1 - \frac{h}{w}\right)^6} \quad \Omega$$

Dr. J.E. Rayas Sánchez (C.S. Walker, *Capacitance, Inductance and Crosstalk Analysis*; Artech, 1990)<sub>17</sub>

## Characterizing Exposed Microstrip Lines (cont)

---

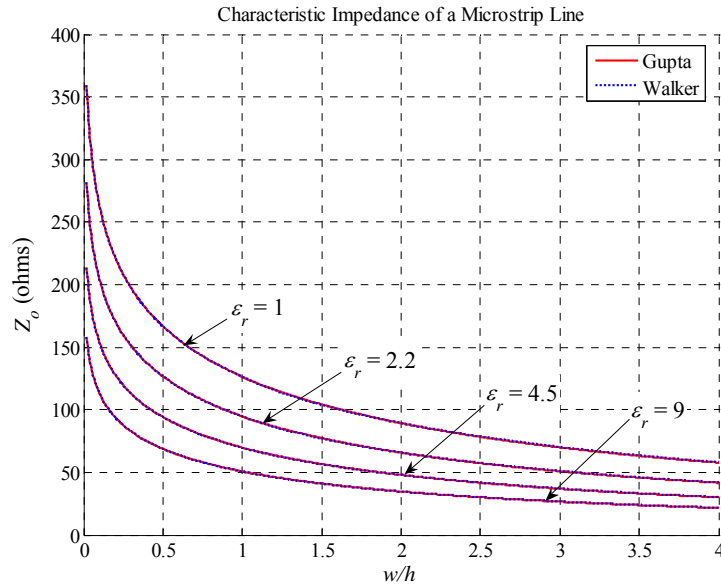
Model 2: Gupta's formulae

$$\text{if } \frac{w}{h} \leq 1, \quad Z_o = \frac{60}{\sqrt{\epsilon_e}} \ln\left(\frac{8h}{w} + \frac{w}{4h}\right) \quad \Omega$$

$$\text{if } \frac{w}{h} > 1, \quad Z_o = \frac{120\pi}{\sqrt{\epsilon_e}} \frac{1}{\left(\frac{w}{h}\right) + 1.393 + 0.667 \ln\left(\frac{w}{h} + 1.444\right)} \quad \Omega$$

Dr. J.E. Rayas Sánchez (K.C. Gupta et. al, *Computer-Aided Design of Microwave Circuits*; Artech, 1981)<sub>18</sub>

## Characterizing Exposed Microstrip Lines (cont)

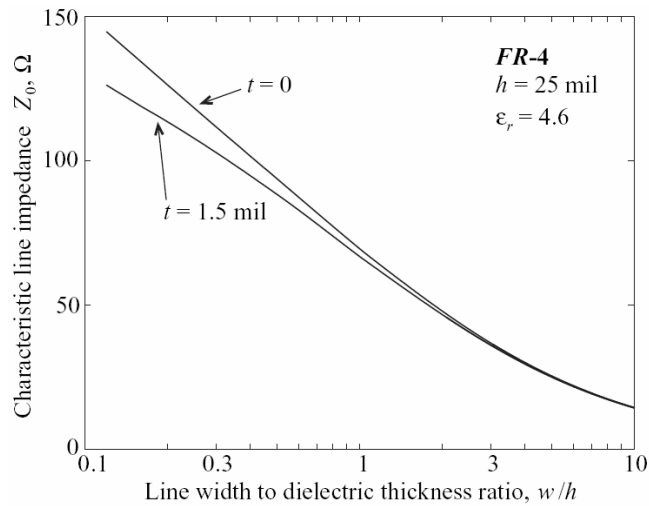


Dr. J.E. Rayas Sánchez

19

## Characterizing Exposed Microstrip Lines (cont)

Effects of  $t \neq 0$  on  $Z_o$



Dr. J.E. Rayas Sánchez

(R. Ludwig and P. Bretchko, *RF Circuit Design*, Prentice Hall, 2000)<sub>20</sub>

## Characterizing Exposed Microstrip Lines (cont)

---

$Z_o$  considering thickness ( $t \neq 0$ )

$$\text{if } \frac{w}{h} \leq 2, \quad Z_o = \frac{60}{\sqrt{\epsilon_e}} \ln\left(\frac{5.98h}{0.8w+t}\right) \quad \Omega$$

$$\text{if } \frac{w}{h} > 2, \quad Z_o = \frac{120\pi}{\sqrt{\epsilon_e}} \frac{1}{\left(\frac{w}{h}\right) + 1.393 + 0.667 \ln\left(\frac{w}{h} + 1.444\right)} \quad \Omega$$

Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>21</sub>

## Embedded Microstrips

---

- Usually PCBs are covered in solder mask, creating embedded microstrip lines in the extreme layers
- The solder mask properties vary among manufacturers
- Typical parameter values for the solder mask are:
  - Thickness: 0.6-0.8 mil
  - Dielectric constant: 3.1-3.3
  - Loss tangent: ~ 0.02
- Analytical models for embedded microstrip lines become very complicated

Dr. J.E. Rayas Sánchez

22

## Effects of the Solder Mask

- Reduce the characteristic impedance,  $Z_o$
- Increase the flight time,  $t_d$
- Increase losses
- ☺ Vendors offer PCBs with “controlled impedance”

b: bare laminate  
s: with solder mask

**Table 9.2** Effects of Solder Mask on Microstrip  $Z_o$ ,  $t_d$ ,  $\alpha$

$w$ (mils)	$w/h$	$Z_{-b}$ ( $\Omega$ )	$Z_{-s}$ ( $\Omega$ )	$t_{d,b}$ (pS/in)	$t_{d,s}$ (pS/in)	$\alpha t_{-b}$ (dB/in)	$\alpha t_{-s}$ (dB/in)
3	2	49	44	151	166	0.30	0.34
3	0.5	89	83	147	158	0.18	0.20
8	2	47	45	155	163	0.19	0.21
8	0.5	92	89	148	154	0.13	0.14

Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>23</sub>

## Lossy vs Lossless Transmission Lines

$$V(z) = V_o^+ [e^{-\gamma z} + \Gamma e^{+\gamma z}]$$

$$I(z) = \frac{V_o^+}{Z_o} [e^{-\gamma z} - \Gamma e^{+\gamma z}]$$

$$\gamma = \sqrt{(R + j\omega L)(G + j\omega C)}$$

$$\gamma \equiv \alpha + j\beta$$

$$Z_o = \sqrt{\frac{R + j\omega L}{G + j\omega C}}$$

$$\Gamma_z(z) = \Gamma e^{+2\gamma z}$$

$$V(z) = V_o^+ [e^{-j\beta z} + \Gamma e^{+j\beta z}]$$

$$I(z) = \frac{V_o^+}{Z_o} [e^{-j\beta z} - \Gamma e^{+j\beta z}]$$

$$\beta = \omega \sqrt{LC} \quad Z_o = \sqrt{\frac{L}{C}}$$

$$\Gamma_z(z) = \Gamma e^{+2j\beta z}$$

$$v(z, t) = |V_o^+| \cos(\omega t - \beta z + \phi^+) e^{-\alpha z} + |V_o^-| \cos(\omega t + \beta z + \phi^-) e^{+\alpha z}$$

Dr. J.E. Rayas Sánchez

24

## Losses in Transmission Lines

- The total loss  $\alpha_t$  is the sum of the conductor and dielectric losses

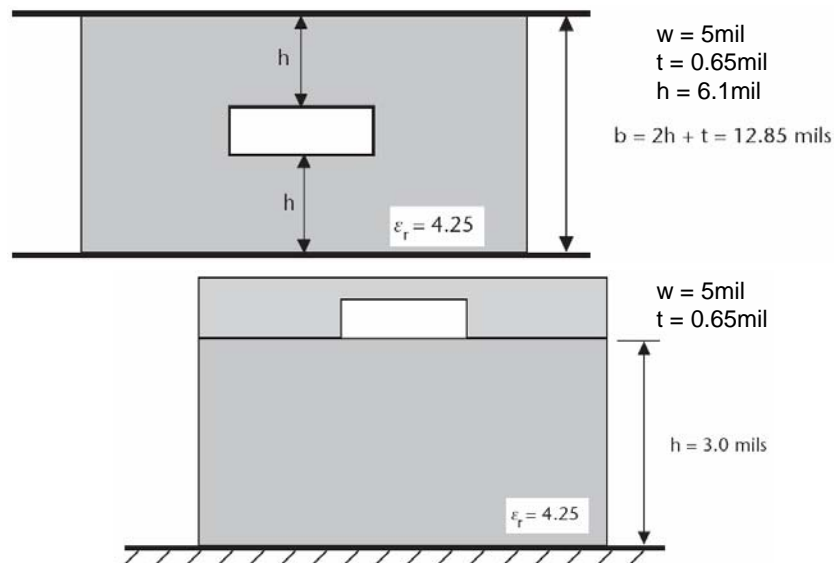
$$\alpha \equiv \alpha_t = \alpha_c + \alpha_d$$

- Conductor losses  $\alpha_c$  are due to the resistive losses in the signal trace and the return path (produced by a conductive current)
- Dielectric losses  $\alpha_d$  are due to the energy lost in the dielectric layers (produced by a displacement current)

Dr. J.E. Rayas Sánchez

25

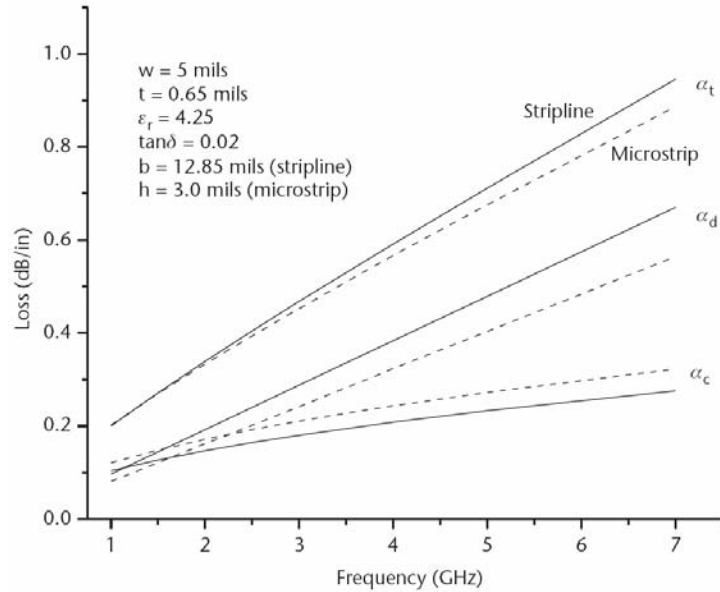
## 50- $\Omega$ Stripline and 50- $\Omega$ Embedded Microstrip



Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>26</sub>

## 50-Ω Stripline and 50-Ω Embedded Microstrip



Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>27</sub>

## Estimating Dielectric Losses

Dielectric losses  $\alpha_d$  can be estimated for striplines and microstrip lines using

$$\alpha_d = 2.318 f \sqrt{\epsilon_e} \tan \delta \quad (\text{dB/inch})$$

with  $f$  in GHz.

Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>28</sub>

## Estimating Conductive Losses in Striplines

---

Conductive losses  $\alpha_c$  can be estimated for striplines using

$$\alpha_c = \frac{2.02 \times 10^{-3} \epsilon_r Z_o k \sqrt{f}}{b} \left[ 1 + \frac{2wk}{b} + \frac{k}{\pi} \left( 1 + \frac{t}{b} \right) \ln \left( \frac{k+1}{k-1} \right) \right] \text{ (dB/inch)}$$

where  $k \equiv \frac{1}{1 - \frac{t}{b}}$

with  $b$ ,  $w$  and  $t$  in mils, and  $f$  in GHz.

Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>29</sub>

## Estimating Conductive Losses in Microstrips

---

Conductive losses  $\alpha_c$  can be estimated for striplines using

$$\alpha_c = \frac{11.411 \sqrt{f}}{h Z_o} \left\{ \left[ 1 - \left( \frac{w_p}{4h} \right)^2 \right] \left[ 1 + \frac{h}{w_p} + \frac{h}{\pi w_p} \left( \ln \left( \frac{2h}{t} \right) - \frac{t}{h} \right) \right] \right\} \text{ (dB/inch)}$$

with  $b$ ,  $w$  and  $t$  in mils, and  $f$  in GHz.

Dr. J.E. Rayas Sánchez

(S. C. Thierauf, *High-Speed Circuit Board Signal Integrity*, Artech, 2004)<sub>30</sub>

## The Low-Loss Transmission Line

---

- It is a line where  $R \ll \omega L$  and  $G \ll \omega C$

$$\gamma \approx j\omega\sqrt{LC} \left[ 1 - \frac{j}{2} \left( \frac{R}{\omega L} + \frac{G}{\omega C} \right) \right]$$

$$\gamma \equiv \alpha + j\beta$$

$$\beta \approx \omega\sqrt{LC} \quad \beta \text{ is almost a linear function of } \omega \text{ (no dispersion)}$$

$$\alpha \approx \frac{1}{2} \left( R\sqrt{\frac{C}{L}} + G\sqrt{\frac{L}{C}} \right) \quad Z_o = \sqrt{\frac{R + j\omega L}{G + j\omega C}} \approx \sqrt{\frac{L}{C}}$$

$$\alpha \approx \frac{1}{2} \left( \frac{R}{Z_o} + GZ_o \right)$$

Dr. J.E. Rayas Sánchez

31

## The Lossy Distorsionless Transmission Line

---

- It is a line where  $R/L = G/C$

$$\text{Since } \gamma = j\omega\sqrt{LC} \sqrt{1 - j \left( \frac{R}{\omega L} + \frac{G}{\omega C} \right) - \frac{RG}{\omega^2 LC}}$$

$$\gamma = j\omega\sqrt{LC} \sqrt{1 - 2j \frac{R}{\omega L} - \frac{R^2}{\omega^2 L^2}}$$

$$\gamma = j\omega\sqrt{LC} \left( 1 - j \frac{R}{\omega L} \right)$$

$$\gamma \equiv \alpha + j\beta$$

$$\beta = \omega\sqrt{LC} \quad \alpha = R\sqrt{\frac{C}{L}}$$

$\beta$  is a linear function of  $\omega$  (non dispersive TL)

Dr. J.E. Rayas Sánchez

32